

# TPS65296-Complete LPDDR4/LPDDR4X Memory Power Solution

# 1 Features

- Synchronous buck converter (VDD2)
  - Input voltage range: 4.5 V to 18 V
  - Output voltage fixed at 1.1 V
  - D-CAP3<sup>™</sup> mode control for fast transient response
  - Continual output current: 8 A
  - Advanced Eco-mode<sup>™</sup> pulse skip
  - Integrated 22-m $\Omega$  / 8.6-m $\Omega$  R<sub>DS(on)</sub> internal power switch
  - 600-kHz switching frequency
  - Internal soft start: 1.6 ms
  - Cycle-by-cycle overcurrent protection
  - Latched output OV/UV protections
- Synchronous buck converter (VDD1)
  - Input voltage range: 3 V to 5.5 V
  - Output voltage fixed at 1.8 V
  - D-CAP3<sup>™</sup> mode control for fast transient response
  - Continual output current: 1 A
  - Advanced Eco-mode<sup>™</sup> pulse skip
  - Integrated 150-m $\Omega$  /120-m $\Omega$  R<sub>DS(on)</sub> internal power switch
  - 580-kHz switching frequency
  - Internal soft start: 1 ms
  - Cycle-by-cycle overcurrent protection
  - Latched output OV/UV protections
- 1.5-A LDO (VDDQ)
  - 1.5-A continual output current
  - Requires only 10 μF of ceramic output capacitor
  - Support high-Z in S3
  - ±30-mV VDDQ output accuracy (DC+AC)
- Low quiescent current: 150 μA
- Power good indicator
- Output discharge function
- Power up and power down sequencing control
- Non-latch for OT and UVLO protections
- 18-pin 3.0-mm × 3.0-mm HotRod™ VQFN package

# 2 Applications

- Notebook, PC computers, and servers
- Ultrabook, tablet computers
- Single-board computer, industrial PC
- Distributed power systems

# 3 Description

The TPS65296 device provides a complete power solution for LPDDR4/LPDDR4X memory system with the lowest total cost and minimum space. It meets the JEDEC standard for LPDDR4/LPDDR4X power-up power-down sequence requirement. TPS65296 integrates two synchronous buck converters (VDD1 and VDD2) and a 1.5-A LDO (VDDQ).

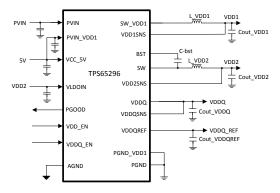
The TPS65296 employs D-CAP3<sup>™</sup> mode with 600kHz switching frequency for fast transient, good load/ line regulation, and support for ceramic output capacitors without an external compensation circuit.

The TPS65296 provides rich functions as well as good efficiency with internal low Rdson power MOSFETs. It supports flexible power state control, placing VDDQ at high-Z in S3 and discharging VDD1, VDD2, and VDDQ in S4/S5 state. Full protection features include OVP, UVP, OCP, UVLO and thermal shutdown protection. The part is available in a thermally enhanced 18-pin HotRod™ VQFN package and is designed to operate under the -40°C to 125°C junction temperature range.

#### Device Information (1)

PART NUMBER	PACKAGE	BODY SIZE (NOM)
TPS65296	VQFN (18)	3.00 mm × 3.00 mm

For all available packages, see the orderable addendum at the end of the data sheet.



**Typical Application** 



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**4 Revision History**NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

CI	hanges from Revision * (September 2019) to Revision A (October 2020)	Page
•	Updated the numbering format for tables, figures and cross-references throughout the document	1
•	Updated Package Information - package outline for pin 16 and pin 18	29
•	Updated Package Information - example board layout for pin 16 and pin 18	29
•	Updated Package Information - example stencil design for pin 16 and pin 18	29



# **5 Pin Configuration and Functions**

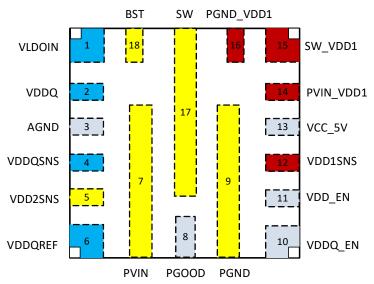


Figure 5-1. 18-Pin VQFN RJE Package (Top View)

**Table 5-1. Pin Functions** 

PIN		1/0	DESCRIPTION
NAME	NO.	- I/O	DESCRIPTION
VLDOIN	1	Р	Power supply input for VDDQ LDO. Connect VDD2 in typical application.
VDDQ	2	0	VDDQ 1.5-A LDO output. It is recommended to connect to 10-μF or larger capacitance for stability.
AGND	3	G	Signal ground
VDDQSNS	4	1	VDDQ output voltage feedback
VDD2SNS	5	ı	VDD2 output voltage feedback
VDDQREF	6	0	Internal reference for VDDQ. Recommend to connect to 0.22-µF or larger capacitance for stability.
PVIN	7	Р	Input power supply for VDD2 buck
PGOOD	8	0	Power good signal open-drain output. PGOOD goes high when VDD1 and VDD2 output voltage are within the target range.
PGND	9	G	Power ground for VDD2 buck
VDDQ_EN	10	ı	VDDQ_EN signal input for VDDQ LDO enable control. For detail control setup, refer to Table 7-1.
VDD_EN	11	I	VDD_EN signal input for VDD1 buck and VDD2 buck enable control. For detail control setup, refer to Table 7-1.
VDD1SNS	12	I	VDD1 output voltage feedback
VCC_5V	13	Р	Power supply for VDD1 and VDD2 buck converter control logic circuit
PVIN_VDD1	14	Р	Input power supply for VDD1 buck
SW_VDD1	15	0	VDD1 switching node connection to the inductor and bootstrap capacitor
PGND_VDD1	16	G	Power ground for VDD1 buck
SW	17	0	VDD2 switching node connection to the inductor and bootstrap capacitor
BST	18	I	High-side MOSFET gate driver bootstrap voltage input for VDD2 buck. Connect a capacitor between the BST pin and the SW pin.



# **6 Specifications**

# **6.1 Absolute Maximum Ratings**

over operating free-air temperature range (unless otherwise noted) (1)

		MIN	MAX	UNIT
	PVIN	-0.3	20	V
	VBST	-0.3	25	V
Input voltage	VBST-SW	-0.3	6	V
put tottage	VDD_EN, VDDQ_EN, VCC_5V, PVIN_VDD1, VLDOIN, VDD1SNS, VDD2SNS, VDDQSNS	-0.3	6	V
	PGND, AGND, PGND_VDD1	-0.3	0.3	V
	SW	-0.3	20	V
	SW (10-ns transient)	-3	22	V
Output voltage	SW_VDD1	-0.3	7	V
	SW_VDD1 (10-ns transient)	-3	8	V
	PGOOD, VDDQ, VDDQREF	-0.3	6	V
T <sub>J</sub> Operating junction temperature	e	-40	150	°C
T <sub>stg</sub> Storage temperature		-55	150	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

# 6.2 ESD Ratings

			VALUE	UNIT
V	Electrostatic	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±2000	V
V <sub>(ESD)</sub>	discharge	Charged-device model (CDM), per JEDEC specification JESD22- V C101 <sup>(2)</sup>	±500	V

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
		PVIN	4.5	18	V
	Input voltage  Output voltage  VDD2 Output current  Operating junction temperatu	VBST	-0.3	23	V
	Input voltage	VBST-SW	-0.3	5.5	V
	pat vallage	VDD_EN, VDDQ_EN, VCC_5V, PVIN_VDD1, VLDOIN, VDD1SNS, VDD2SNS, VDDQSNS	-0.3	5.5	V
		PGND, AGND, PGND_VDD1	-0.3	0.3	V
		SW	-0.3	18	V
		SW (10-ns transient)	-3	20	V
	Output voltage	SW_VDD1	-0.3	6	V
		SW_VDD1 (10-ns transient)	-2	7	V
		PGOOD, VDDQ, VDDQREF	-0.3	5.5	V
I <sub>VDD2OUT</sub>	VDD2 Output current			8	А
TJ	Operating junction tempera	ature	-40	125	°C

Product Folder Links: TPS65296

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



# **6.4 Thermal Information**

		TPS65296	
	THERMAL METRIC(1)	RJE (VQFN)	UNIT
		18 PINS	
R <sub>0JA</sub>	Junction-to-ambient thermal resistance	58.1	°C/W
R <sub>0JC(top)</sub>	Junction-to-case (top) thermal resistance	26.1	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	17.7	°C/W
ΨЈТ	Junction-to-top characterization parameter	0.5	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	17.7	°C/W
R <sub>θJC(bot)</sub>	Junction-to-case (bottom) thermal resistance	N/A	°C/W

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report.

# **6.5 Electrical Characteristics**

T<sub>J</sub>=-40°C to 125°C, V<sub>PVIN</sub>=12V, V<sub>PVIN</sub> <sub>VDD1</sub>=5V (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
INPUT SUF	PPLY VOLTAGE					
		$V_{VDD\_EN} = V_{VDDQ\_EN} = 0 V$		5		μA
I <sub>VCC_5V</sub>	VCC_5V supply current	V <sub>VDD_EN</sub> = 5 V, V <sub>VDDQ_EN</sub> = 0 V, no load		110		μA
		V <sub>VDD_EN</sub> = V <sub>VDDQ_EN</sub> = 5 V, no load		150		μA
VIN	PVIN input voltage range		4.5		18	V
UVLO		'				
		Wake up VCC_5V voltage		4.1	4.5	V
UVLO	VCC_5V under-voltage lockout	Shut down VCC_5V voltage	3.3	3.6		V
		Hysteresis VCC_5V voltage		500		mV
VDD2		'			<u>'</u>	
V <sub>VDD2SNS</sub>	VDD2 sense voltage		1.1	1.115	1.13	V
I <sub>VDD2SNS</sub>	VDD2SNS input current	V <sub>VDD2SNS</sub> =1.1 V		40		μA
I <sub>VDD2DIS</sub>	VDD2 discharge current	V <sub>VDD_EN</sub> = V <sub>VDDQ_EN</sub> = 0 V, V <sub>VDD2SNS</sub> = 0.5 V		12		mA
t <sub>VDD2SS</sub>	VDD2 soft-start time			1.6	2.65	ms
t <sub>VDD2DLY</sub>	VDD2 ramp up delay time		1.3	2	3.5	ms
R <sub>DSONH</sub>	High-side switch resistance	T <sub>J</sub> = 25°C, V <sub>VCC_5V</sub> = 5V		22		mΩ
R <sub>DSONL</sub>	Low-side switch resistance	T <sub>J</sub> = 25°C, V <sub>VCC_5V</sub> = 5V		8.6		mΩ
I <sub>VDD2OCL</sub>	Low-side valley current limited	V <sub>OUT</sub> = 1.1 V, L = 0.68 μH	8.2	9.8	11.5	Α
f <sub>sw</sub>	VDD2 switching freqency			600		kHz
t <sub>OFF(MIN)</sub>	Minimum off time			198		ns
PGOOD (V	DD2, VDD1)	1	'		1	
		VDD2SNS / VDD1SNS falling (Fault)		87		%
V	DCCCD throubold	VDD2SNS / VDD1SNS rising (Good)		93		%
$V_{THPG}$	PGOOD threshold	VDD2SNS / VDD1SNS rising (Fault)		115		%
		VDD2SNS / VDD1SNS falling (Good)		110		%
I <sub>PGMAX</sub>	PG sink current	$V_{PGOOD}$ =0.5V, $V_{VDD\_EN}$ = $V_{VDDQ\_EN}$ = 5 V, no load		46		mA
t <sub>PGDLY</sub>	PG start-up delay	PG from low to high		1		ms
VDD1					1	
V <sub>VDD1SNS</sub>	VDD1 sense voltage		1.75	1.8	1.85	V
I <sub>VDD1SNS</sub>	VDD1SNS input current	V <sub>VDD1SNS</sub> =1.8 V		20		μA

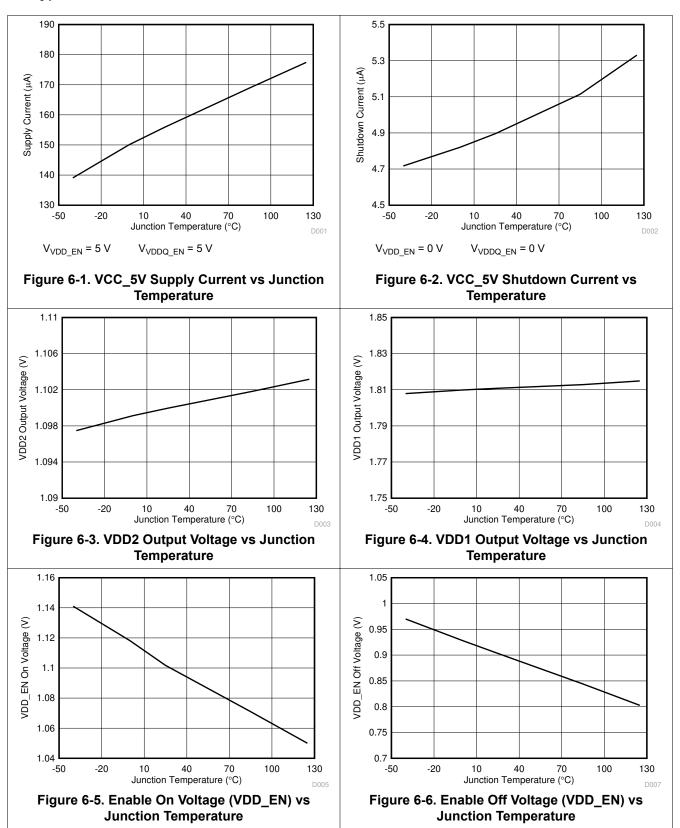


T<sub>J</sub>=-40°C to 125°C, V<sub>PVIN</sub>=12V, V<sub>PVIN</sub> V<sub>DD1</sub>=5V (unless otherwise noted)

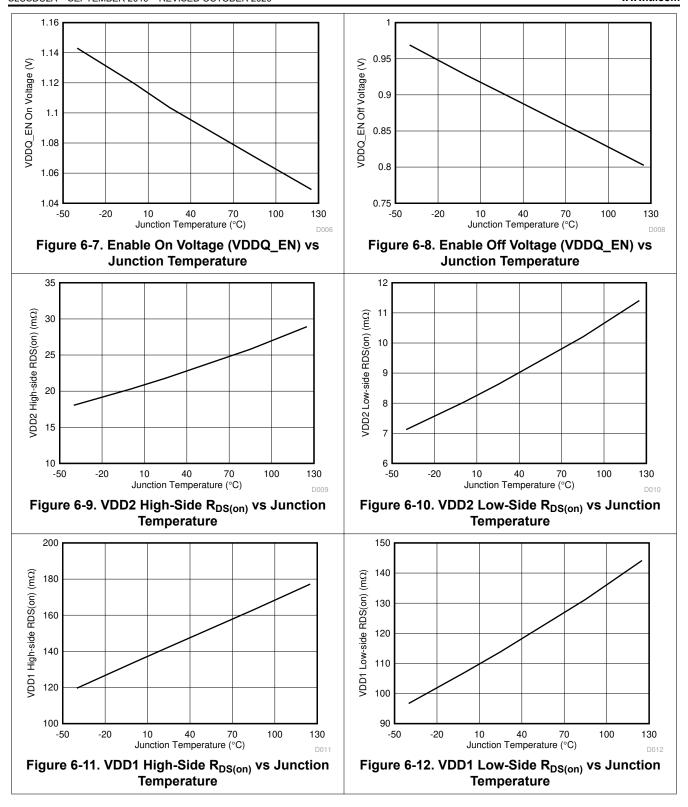
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
I <sub>VDD1DIS</sub>	VDD1 discharge current	$V_{VDD\_EN} = V_{VDDQ\_EN} = 0 \text{ V}, V_{VDD1SNS} = 0.5 \text{ V}$		12		mA
t <sub>VDD1SS</sub>	VDD1 soft-start time			1.0	2	ms
R <sub>DSONH</sub>	High-side switch resistance	T <sub>J</sub> = 25°C, V <sub>PVIN_VDD1</sub> = 5V, V <sub>VCC_5V</sub> = 5V		150		mΩ
R <sub>DSONL</sub>	Low-side switch resistance	$T_J = 25$ °C, $V_{PVIN\_VDD1}=5V$ , $V_{VCC\_5V}=5V$		120		mΩ
I <sub>VDD1OCL</sub>	Low-side valley current limited	V <sub>VDD1SNS</sub> = 1.8 V, L = 4.7 μH	1.05	1.6	2.1	Α
f <sub>sw</sub>	VDD1 switching frequency			580		kHz
t <sub>OFF(MIN)</sub>	Minimum off time			195		ns
t <sub>OOA</sub>	OOA mode operation period	V <sub>VDD1SNS</sub> =1.8 V		31		μs
OVP AND U	VP (VDD2, VDD1)					
V <sub>OVP</sub>	OVP threshold voltage	OVP detect voltage	120	125	130	%
V <sub>UVP1</sub>	UVP threshold voltage	UVP detect voltage	57.5	62.5	67.5	%
tovpdly	OVP delay			20		μs
t <sub>UVPDLY</sub>	UVP delay			250		μs
VDDQ OUTF	PUT				<u> </u>	
V <sub>VDDQ</sub>	Output voltage	T <sub>J</sub> = 25°C, I <sub>VDDQ</sub> ≤1.5A	0.57	0.6	0.63	V
I <sub>VDDQOCLSRC</sub>	Source current limit	$V_{VDD2SNS}$ = 1.1 V, $V_{VDDQ}$ = $V_{VDDQSNS}$ = 0.5 V	1.7	2.2		Α
I <sub>VDDQLK</sub>	Leakage current	T <sub>J</sub> = 25°C, V <sub>VDD_EN</sub> = 5 V, V <sub>VDDQ_EN</sub> = 5 V			5	
I <sub>VDDQSNSBIA</sub> s	VDDQSNS input bias current	V <sub>VDD_EN</sub> = 5 V, V <sub>VDDQ_EN</sub> = 5 V	-0.5	0	0.5	μA
I <sub>VDDQSNSLK</sub>	VDDQSNS leakage current	V <sub>VDD_EN</sub> = 5 V, V <sub>VDDQ_EN</sub> = 0 V	-1	0	1	
I <sub>VDDQDLY</sub>	VDDQ output delay relative to VDDQ_EN				35	us
I <sub>VDDQDIS</sub>	VDDQ discharge current	$T_J = 25^{\circ}C$ , $V_{VDD\_EN} = V_{VDDQ\_EN} = 0$ V, $V_{VDD2SNS} = 1.1$ V, $V_{VDDQ} = 0.5$ V		5.7		mA
VDD_EN, V	DDQ_EN LOGIC THRESHOLD		-			
V <sub>IH</sub>	VDD_EN/VDDQ_EN high-level voltage		1.35			V
V <sub>IL</sub>	VDD_EN/VDDQ_EN low-level voltage				0.5	V
R <sub>TOGND</sub>	VDD_EN/VDDQ_EN resistance to GND			500		kΩ
THERMAL P	PROTECTION				1	1
T <sub>OTP</sub>	OTP trip threshold			150		°C
T <sub>OTPHSY</sub>	OTP hysteresis			20		°C

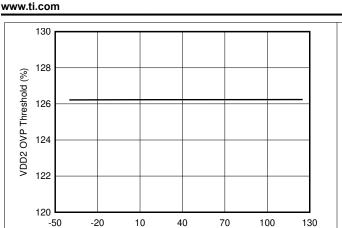
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# **6.6 Typical Characteristics**









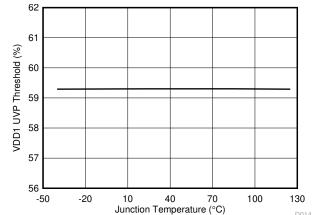
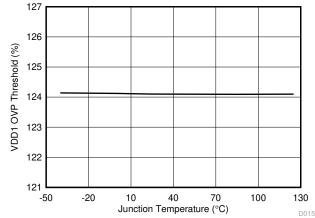


Figure 6-13. VDD2 OVP Threshold vs Junction Temperature

Junction Temperature (°C)

Figure 6-14. VDD2 UVP Threshold vs Junction Temperature



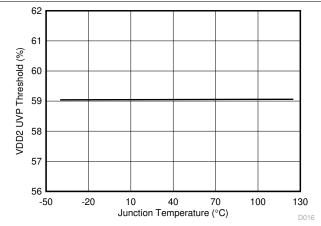
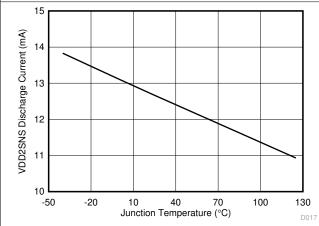


Figure 6-15. VDD1 OVP Threshold vs Junction Temperature

Figure 6-16. VDD1 UVP Threshold vs Junction Temperature



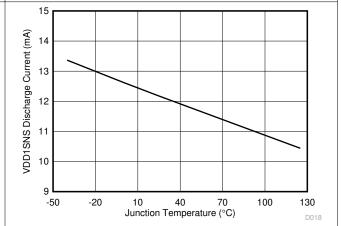
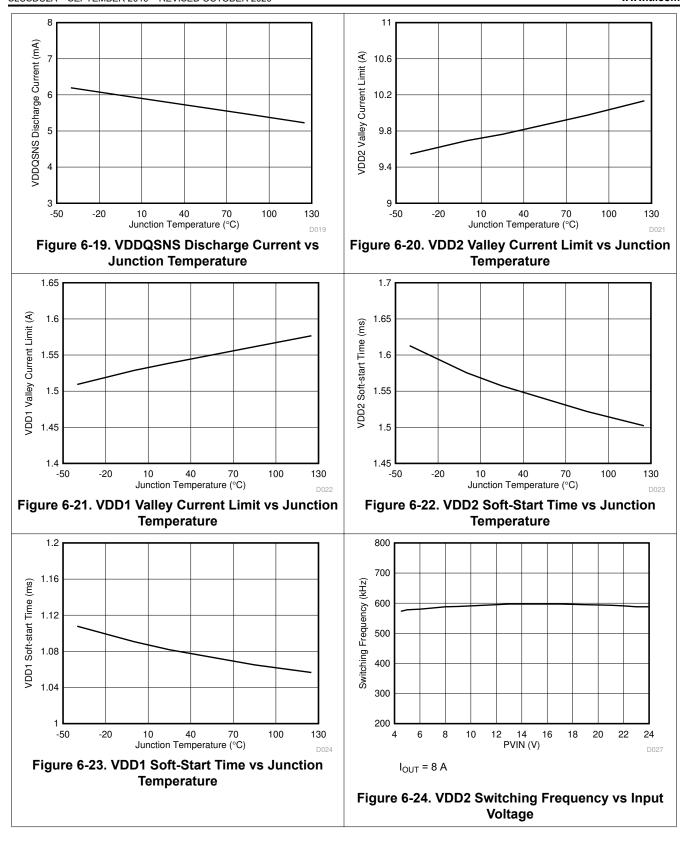


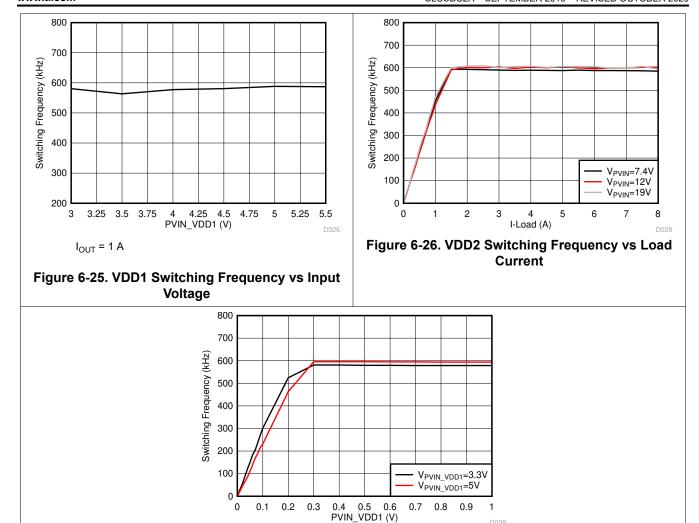
Figure 6-17. VDD2SNS Discharge Current vs Junction Temperature

Figure 6-18. VDD1SNS Discharge Current vs Junction Temperature





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# 7 Detailed Description

### 7.1 Overview

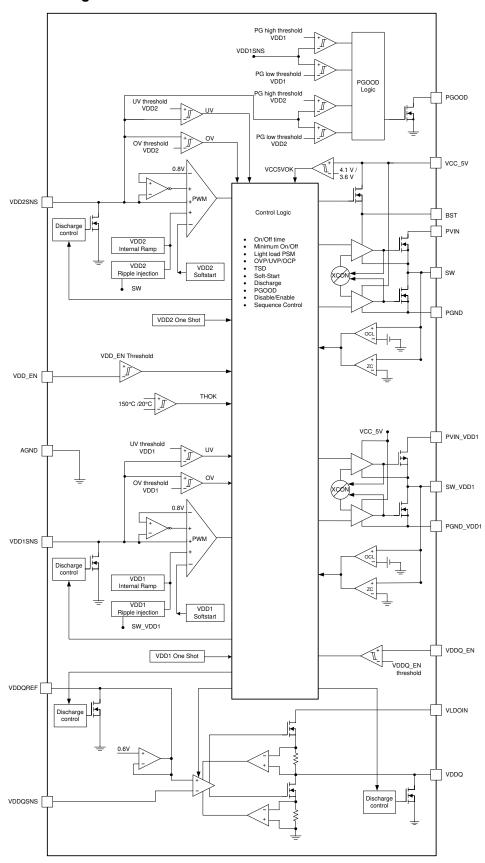
The TPS65296 integrates two synchronous step-down buck converters and a LDO to support complete LPDDR4/LPDDR4X power solution. The VDD2 buck converter has fixed 1.1-V output and supports continuous 8-A output current, and it can operate from 4.5-V to 18-V PVIN input voltage. The VDD1 buck converter has the fixed 1.8-V output and supports continuous 1-A output current, and can operate from 3-V to 5.5-V PVIN\_VDD1 input voltage. The VDDQ LDO has continuous 1.5-A output current capability.

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Product Folder Links: TPS65296



# 7.2 Functional Block Diagram



# 7.3 Feature Description

# 7.3.1 PWM Operation and D-CAP3 Control

The main control loop of the two bucks is adaptive on-time pulse width modulation (PWM) controller that supports a proprietary DCAP3 mode control. The DCAP3 mode control combines adaptive on-time control with an internal compensation circuit for pseudo-fixed frequency and low external component count configuration with both low-ESR and ceramic output capacitors. It is stable even with virtually no ripple at the output. The TPS65296 also includes an error amplifier that makes the output voltage very accurate.

At the beginning of each cycle, the high-side MOSFET is turned on. This MOSFET is turned off after internal one-shot timer expires. This one-shot duration is set proportional to the converter input voltage, VIN, and is inversely proportional to the output voltage, VO, to maintain a pseudo-fixed frequency over the input voltage range, hence it is called adaptive on-time control. The one-shot timer is reset and the high-side MOSFET is turned on again when the feedback voltage falls below the reference voltage. An internal ripple generation circuit is added to reference voltage for emulating the output ripple, this enables the use of very low-ESR output capacitors such as multi-layered ceramic caps (MLCC). No external current sense network or loop compensation is required for DCAP3 control topology.

Both VDD1 buck and VDD2 buck include an error amplifier that makes the output voltage very accurate. For any control topology that is compensated internally, there is a range of the output filter it can support. The output filter used with the TPS65296 is a low-pass L-C circuit. This L-C filter has a double-pole frequency described in Equation 1.

$$f_{P} = \frac{1}{2 \times \pi \times \sqrt{L_{OUT} \times C_{OUT}}}$$
(1)

At low frequencies, the overall loop gain is set by the internal output set-point resistor divider network and the internal gain of the TPS65296. The low-frequency L-C double pole has a 180 degree in-phase. At the output filter frequency, the gain rolls off at a -40 dB per decade rate and the phase drops rapidly. The internal ripple generation network introduces a high-frequency zero that reduces the gain roll off from -40 dB to -20 dB per decade and increases the phase to 90 degree one decade above the zero frequency. The internal ripple injection high-frequency zero is related to the switching frequency. The inductor and capacitor selected for the output filter must be such that the double pole is placed close enough to the high-frequency zero, so that the phase boost provided by this high-frequency zero provides adequate phase margin for the stability requirement. The crossover frequency of the overall system should usually be targeted to be less than one-fifth of the switching frequency ( $F_{SW}$ ).

#### 7.3.2 Advanced Eco-mode Control

The VDD1 buck and VDD2 buck are designed with advanced Eco-mode control schemes to maintain high light load efficiency. As the output current decreases from heavy load conditions, the inductor current is also reduced and eventually comes to a point where the rippled valley touches zero level, which is the boundary between continuous conduction and discontinuous conduction modes. The rectifying MOSFET is turned off when the zero inductor current is detected. As the load current further decreases, the converter runs into discontinuous conduction mode. The on-time is kept almost the same as it was in the continuous conduction mode, so that it takes longer time to discharge the output capacitor with smaller load current to the level of the reference voltage. This makes the switching frequency lower, proportional to the load current, and keeps the light load efficiency high. The light load current where the transition to Eco-mode operation happens (I<sub>OUT(LL)</sub>) can be calculated from Equation 2.

$$I_{OUT(LL)} = \frac{1}{2 \times L_{OUT} \times F_{SW}} \times \frac{(V_{IN} - V_{OUT}) \times V_{OUT}}{V_{IN}}$$
(2)

After identifying the application requirements, design the output inductance ( $L_{OUT}$ ) so that the inductor peak-to-peak ripple current is approximately between 20% and 30% of the  $I_{OUT(max)}$  (peak current in the application). It is

also important to size the inductor properly so that the valley current does not hit the negative low-side current limit.

#### 7.3.3 Soft Start and Prebiased Soft Start

The VDD2 buck has an internal 1.6-ms soft start and VDD1 buck has an internal 1-ms soft start. Provide the voltage supply to PVIN, PVIN VDD1, and VCC 5V before asserting VDD EN to be high. When the VDD EN pin becomes high, the internal soft-start function begins ramping up the reference voltage to the PWM comparator.

If the output capacitor is prebiased at start-up, the devices initiate switching and start ramping up only after the internal reference voltage becomes greater than the feedback voltage. This scheme ensures that the converters ramp up smoothly into regulation point.

#### 7.3.4 Power Good

The Power Good (PGOOD) pin is an open-drain output. Once the VDD1SNS and VDD2SNS pins voltage are between 90% and 110% of the target output voltage, the PGOOD is deasserted and floats after a 1-ms de-glitch time. A pullup resistor of 100 k $\Omega$  is recommended to pull the voltage up to VCC 5V. The PGOOD pin is pulled low when:

- the VDD1SNS pin voltage or VDD2SNS pin voltage is lower than 85% or greater than 115% of the target output voltage,
- in an OVP, UVP, or thermal shutdown event,
- or during the soft-start period.

# 7.3.5 Overcurrent Protection and Undervoltage Protection

Both VDD1 and VDD2 bucks have the overcurrent protection and undervoltage protection, and the implementation is same. The output overcurrent limit (OCL) is implemented using a cycle-by-cycle valley detect control circuit. The switch current is monitored during the OFF state by measuring the low-side FET drain-tosource voltage. This voltage is proportional to the switch current. To improve accuracy, the voltage sensing is temperature compensated.

During the on-time of the high-side FET switch, the switch current increases at a linear rate determined by Vin, Vout, the on-time, and the output inductor value. During the on-time of the low-side FET switch, this current decreases linearly. The average value of the switch current is the load current IOLIT. If the monitored current is above the OCL level, the converter maintains low-side FET on and delays the creation of a new set pulse, even the voltage feedback loop requires one, until the current level becomes OCL level or lower. In subsequent switching cycles, the on-time is set to a fixed value and the current is monitored in the same manner.

There are some important considerations for this type of overcurrent protection. When the load current is higher than the overcurrent threshold by one half of the peak-to-peak inductor ripple current, the OCL is triggered and the current is being limited, the output voltage tends to drop because the load demand is higher than what the converter can support. When the output voltage falls below 60% of the target voltage, the UVP comparator detects it, the output will be discharged and latched after a wait time of 256 µs. When the overcurrent condition is removed, the output voltage is latched till the VDD\_EN is toggled or repower the VCC\_5V power input.

#### 7.3.6 Overvoltage Protection

Both VDD1 and VDD2 bucks have the overvoltage protection feature and have the same implementation. When the output voltage becomes higher than 125% of the target voltage, the OVP comparator output goes high, and then the output will be discharged and latched after a wait time of 20 µs. When the over current condition is removed, the output voltage is latched till the VDD EN is toggled or repower the VCC 5V power input.

# 7.3.7 UVLO Protection

Undervoltage Lockout protection (UVLO) monitors the VCC 5V power input. When the voltage is lower than UVLO threshold voltage, the device is shut off and outputs are discharged. This is a non-latch protection.

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#### 7.3.8 Output Voltage Discharge

The VDD1 buck, VDD2 buck, and VDDQ LDO block all have the discharge function by using internal MOSFETs, which are connected to the corresponding output terminals VDD1SNS, VDD2SNS, and VDDQ. The discharge is slow due to the lower current capability of these MOSFETs.

#### 7.3.9 Thermal Shutdown

The TPS65296 monitors the internal die temperature. If the temperature exceeds the threshold value (typically 150°C), the device is shut off and the output will be discharged. This is a non-latch protection. The device restarts switching when the temperature goes below the thermal shutdown recover threshold.

#### 7.4 Device Functional Modes

#### 7.4.1 Light Load Operation for VDD1 Buck and VDD2 Buck

When the load is light on the VDD1 or VDD2 output, the buck enters pulse skip mode after the inductor current crosses zero. This is the Eco-mode which improves the efficiency at light load with a lower switching frequency. Each switching cycle is followed by a period of energy saving sleep time. The sleep time ends when the VDD1SNS or VDD2SNS voltage falls below the Eco-mode threshold voltage. As the output current decreases, the period time between switching pulses increases.

# 7.4.2 Output State Control

The TPS65296 has two enable input pins (VDD\_EN and VDDQ\_EN) to provide simple control scheme of output state. All of VDD1, VDD2, and VDDQ are turned on at S0 state (VDD EN=VDDQ EN=high). In S3 state (VDDQ\_EN=low, VDD\_EN=high), VDD1 and VDD2 voltages are kept on while VDDQ is turned off and left at high impedance state (high-Z). The VDDQ output floats and does not source current in this state. In S4/S5 states (VDD EN=VDDQ EN =low), all of the three outputs are turned off and discharged to GND. Each state code represents as follows: S0 = full ON, S3 = suspend to RAM (STR), S4 = suspend to disk (STD), S5 = soft OFF (see Table 7-1).

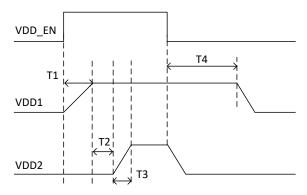
STATE VDDQ EN VDD EN VDD1 VDD2 **VDDQ** S0 ΗΙ ON ON ON HI S3 LO ΗΙ ON ON OFF (High-Z) S5/S4 LO LO OFF (discharge) OFF (discharge) OFF (discharge)

Table 7-1. VDDQ\_EN and VDD\_EN Control for Output State

### 7.4.3 Output Sequence Control

There are specific sequencing requirements for the LPDDR4/LPDDR4X VDD1 and VDD2 rails. The TPS65296 follows the power rail sequence requirements as shown in Figure 7-1 and Figure 7-2. VDD1 is greater than VDD2 at all times during ramp up, operating, and ramp down. The VDDQ output ramp and stable within 35 µs after VDDQ EN asserted.

Product Folder Links: TPS65296



T1: 0.5ms to 2ms T3: 0.5ms to 2ms T2: 2.0ms T4: 30ms to 60ms

Figure 7-1. Power Sequence, VDD1 and VDD2 versus VDD\_EN

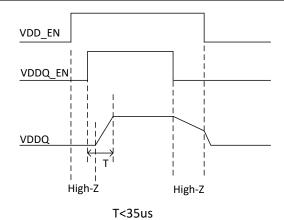


Figure 7-2. Power Sequence, VDDQ versus VDDQ\_EN

# 8 Application and Implementation

#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

# 8.1 Application Information

The TPS65296 device provides a complete power solution for LPDDR4/LPDDR4X memory system. Table 8-1 shows the power requirements for LPDDR4 and LPDDR4X.

Table 8-1. LPDDR4/LPDDR4X Application

	VDD1	VDD2	VDDQ
LPDDR4	YES	YES	NO(Leave this pin floating)
LPDDR4X	YES	YES	YES

The schematic of Figure 8-1 shows a typical application for LPDDR4X. For VDD2 buck, the PVIN supports 4.5-V to 18-V input range with 1.1-V VDD2 output, the continuous current capability is 8 A. Usually the PVIN\_VDD1 and VCC\_5V can share one 5-V power input and supports 1.8-V VDD1 output with 1-A continuous current capability, and the PVIN\_VDD1 can be lowered down to a 3.3-V power supply. The VLDOIN power input usually is connected to VDD2 output, while also it can be connected to external 1.1-V power supply input. The schematic of Figure 8-2 shows a typical application for LPDDR4. The TPS65296 can be used for LPDDR4 when connecting VDDQ\_EN pin to GND to disable the LDO and leave VDDQ/VDDQSNS pin floating. It doesn't need input cap for VLDOIN and output cap for VDDQ compare with the application in LPDDR4X. While it also need to connect VLDOIN to VDD2 or external 1.1-V power supply for internal power supply.

#### 8.2 Typical Application

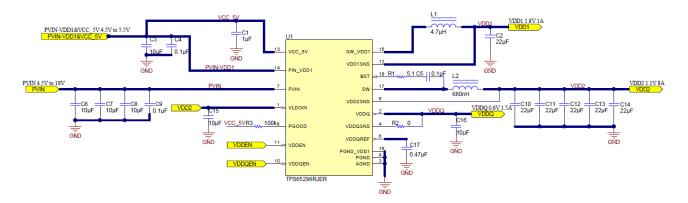


Figure 8-1. LPDDR4X Application Schematic

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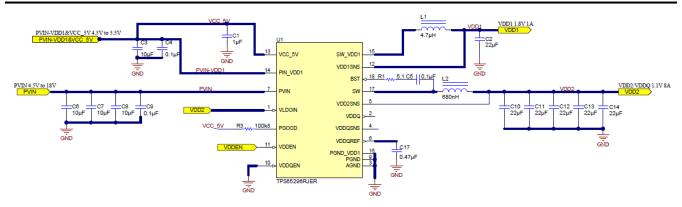


Figure 8-2. LPDDR4 Application Schematic

# 8.2.1 Design Requirements

Table 8-2 lists the design parameters for this example.

Table 8-2. Design Parameters

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
VDD2 OUTPL	 JT					
V <sub>OUT</sub>	Output voltage			1.115		V
I <sub>OUT</sub>	Output current			8		Α
ΔV <sub>OUT</sub>	Transient response	8-A load step		±55		mV
V <sub>IN</sub>	Input voltage		4.5	12	18	V
V <sub>OUT(ripple)</sub>	Output voltage ripple			30		mV <sub>(P-P)</sub>
F <sub>SW</sub>	Switching frequency			600		kHz
VDD1 OUTPL	JT .					
V <sub>OUT</sub>	Output voltage			1.8		V
I <sub>OUT</sub>	Output current			1		Α
$\Delta V_{OUT}$	Transient response	1-A load step		±90		mV
V <sub>IN</sub>	Input voltage		3	5	5.5	V
V <sub>OUT(ripple)</sub>	Output voltage ripple			30		mV <sub>(P-P)</sub>
F <sub>SW</sub>	Switching frequency			580		kHz
OTHERS						
V	Start VCC_5V input voltage	VCC_5V Input voltage rising		Internal UVLO		V
V <sub>VCC_5V</sub>	Stop VCC_5V input voltage	VCC_5V Input voltage falling		Internal UVLO		V
	Light load operating mode			ECO		

#### 8.2.2 Detailed Design Procedure

#### 8.2.2.1 External Component Selection

#### 8.2.2.1.1 Inductor Selection

The inductor ripple current is filtered by the output capacitor. A higher inductor ripple current means the output capacitor should have a ripple current rating higher than the inductor ripple current. See Table 8-3 for recommended inductor values.

The RMS and peak currents through the inductor can be calculated using Equation 3 and Equation 4. It is important that the inductor is rated to handle these currents.

$$IL(rms) = \sqrt{\left(I_{OUT}^2 + \frac{1}{12} \times \left(\frac{V_{OUT} \times \left(V_{IN(max)} - V_{OUT}\right)}{V_{IN(max)} \times L_{OUT} \times F_{SW}}\right)^2\right)}$$
(3)

$$I_{L(peak)} = I_{OUT} + \frac{I_{OUT(ripple)}}{2}$$
(4)

During transient and short-circuit conditions, the inductor current can increase up to the current limit of the device so it is safe to choose an inductor with a saturation current higher than the peak current under current limit condition.

#### 8.2.2.1.2 Output Capacitor Selection

After selecting the inductor the output capacitor needs to be optimized. In DCAP3, the regulator reacts within one cycle to the change in the duty cycle so the good transient performance can be achieved without needing large amounts of output capacitance. The recommended output capacitance range is given in Table 8-3.

Ceramic capacitors have very low ESR, otherwise the maximum ESR of the capacitor should be less than  $V_{OUT(ripple)}/I_{OUT(ripple)}$ .

V <sub>OUT</sub> (V)	F <sub>sw</sub> (kHz)	L <sub>OUT</sub> (μH)	C <sub>OUT(min)</sub> (μF)	C <sub>OUT(max)</sub> (μF)		
	600	0.68	88	142		
1.1	600	0.56	88	142		
	600	0.47	88	142		
	580	6.8	20	66		
1.8	580	4.7	20	66		
	580	3.3	20	66		

Table 8-3. Recommended Component Values

For VDDQ output, high quality X5R or X7R 10- $\mu$ F capacitor is recommended and a 0.47  $\mu$ F is recommended for VDDQREF output.

#### 8.2.2.1.3 Input Capacitor Selection

The TPS65296 requires input decoupling capacitors on both power supply input PVIN and PVIN\_VDD1, and the bulk capacitors are needed depending on the application. The minimum input capacitance required is given in Equation 5.

$$C_{IN(min)} = \frac{I_{OUT} \times V_{OUT}}{V_{INripple} \times V_{IN} \times F_{SW}}$$
(5)

TI recommends using a high-quality X5R or X7R input decoupling capacitors of 30  $\mu$ F on the VDD2 buck input voltage pin PVIN, and 10  $\mu$ F on the VDD1 buck input voltage pin PVIN\_VDD1. The voltage rating on the input capacitor must be greater than the maximum input voltage. The capacitor must also have a ripple current rating

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greater than the maximum input current ripple of the application. The input ripple current is calculated by Equation 6:

$$I_{CIN(rms)} = I_{OUT} \times \sqrt{\frac{V_{OUT}}{V_{IN(min)}}} \times \frac{(V_{IN(min)} - V_{OUT})}{V_{IN(min)}}$$
(6)

An additional  $0.1-\mu F$  capacitor from PVIN to ground and from PVIN\_VDD1 to ground is optional to provide additional high frequency filtering. One ceramic capacitor of 10  $\mu F$  is recommended for the decoupling capacitor on VLDOIN pin for providing stable power on VDDQ LDO block. A 1- $\mu F$  ceramic capacitor is needed for the decoupling capacitor on VCC\_5V input.

# 8.2.2.1.4 Bootstrap Capacitor and Resistor Selection

A 0.1- $\mu$ F ceramic capacitor serialized with a 5.1- $\Omega$  resistor is recommended between the BST and SW pin for proper operation. TI recommends using a ceramic capacitor.

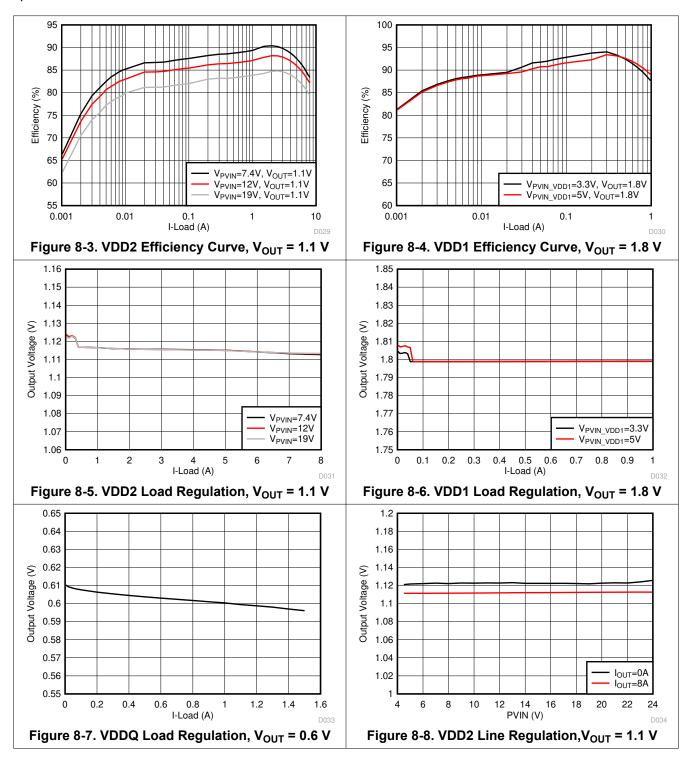
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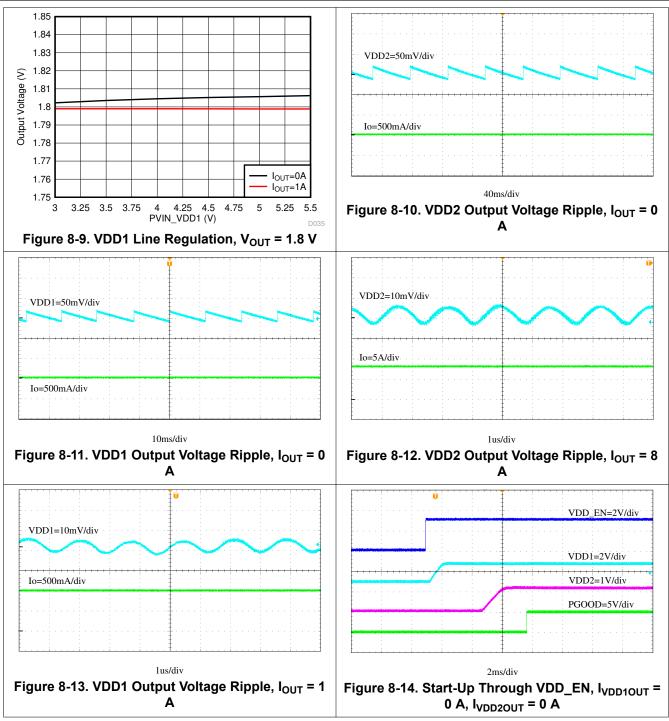


#### 8.2.3 Application Curves

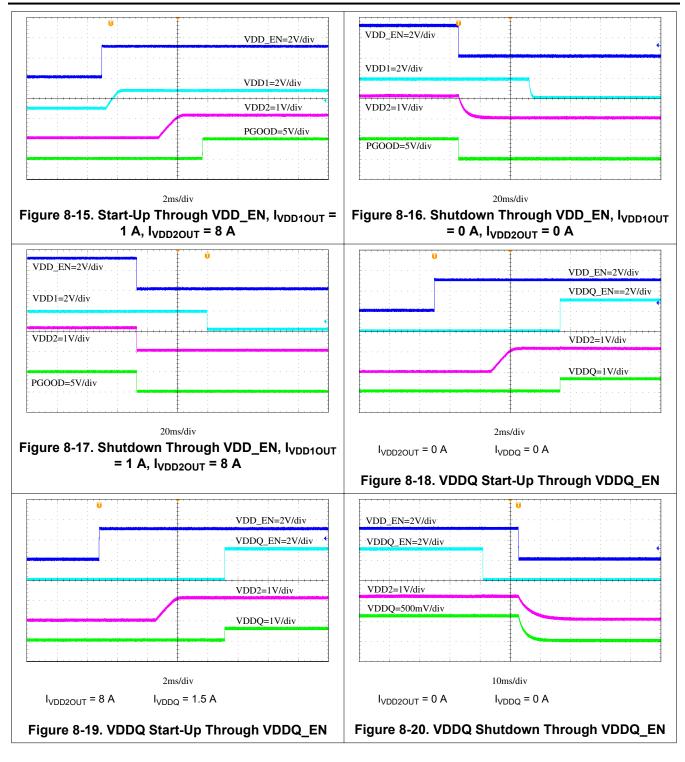
Figure 8-3 through Figure 8-30 apply to the circuit of Figure 8-1.  $V_{IN}$  = 12 V.  $T_A$  = 25°C unless otherwise specified.



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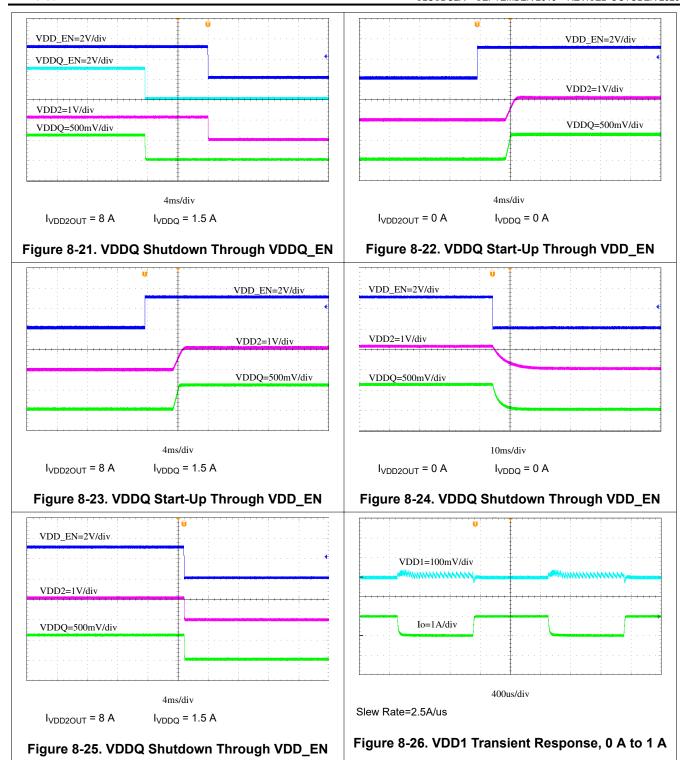




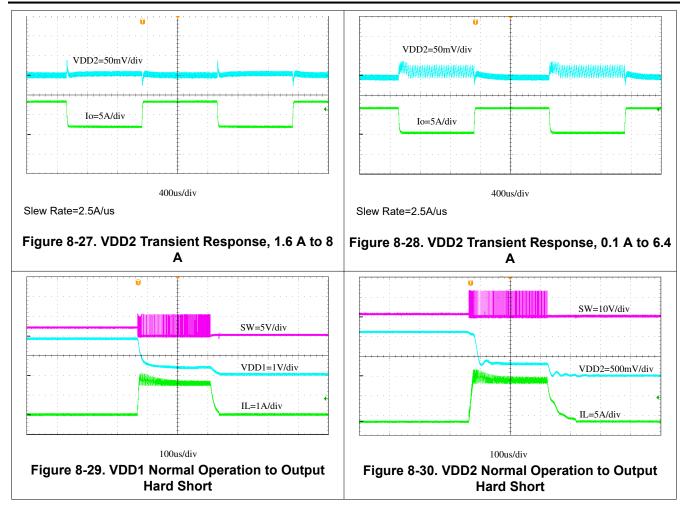


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# 9 Power Supply Recommendations

The TPS65296 is designed for LPDDR4/LPDDR4X complete power solution. PVIN is the power input for VDD2 buck, PVIN\_VDD1 is the power input for VDD1 buck, VLDOIN input is for VDDQ LDO power supply, VCC\_5V is power supply for internal control logic. Below lists the power on sequence scenarios.

- VDD\_EN is high before PVIN or PVIN\_VDD1 has the power input, VCC\_5V power supply must be provided
  after or same time with PVIN or PVIN\_VDD1, otherwise the output will be latched. This latch can be
  recovered by toggling the VDD\_EN pin or re-power the VCC\_5V.
- VDD\_EN is low before PVIN and PVIN\_VDD1 has the power input, then there is no power supply input sequence requirement for VCC 5V, PVIN and PVIN VDD1.

# 10 Layout

# 10.1 Layout Guidelines

- A four-layer PCB is recommended for good thermal performance and with maximum ground plane. 3-inch × 3-inch, four-layer PCB with 2-oz. copper is used as example.
- Place the decoupling capacitors right across PVIN, PVIN\_VDD1, and VLDOIN as close as possible.
- Place output inductors and capacitors with IC at the same layer, SW routing should be as short as possible to
  minimize EMI, and should be a width plane to carry big current, enough vias should be added to the PGND
  connection of output capacitor and also as close to the output pin as possible. Reserve some space between
  VDD1 choke and VDD2 choke, just minimize radiation crosstalk.
- Place BST resistor and capacitor with IC at the same layer, close to BST and SW plane, >15 mil width trace is recommended to reduce line parasitic inductance.
- VDD1SNS/VDD2SNS/VDDQSNS can be 10 mil and must be routed away from the switching node, BST node or other high efficiency signal.
- PVIN and PVIN\_VDD1 trace must be wide to reduce the trace impedance and provide enough current capability.
- Output capacitors for VDDQ and VDDQREF should be put as close as output pin.

# 10.2 Layout Example

Figure 10-1 shows the recommended top-side layout. Component reference designators are the same as the circuit shown in Figure 8-1.

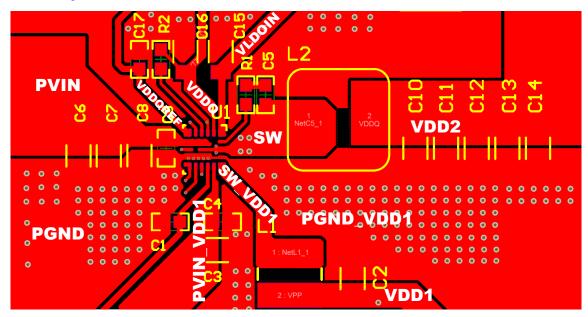


Figure 10-1. Top-Side Layout

# 11 Device and Documentation Support

# 11.1 Device Support

#### 11.1.1 Third-Party Products Disclaimer

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ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

# 11.6 Glossary

**TI Glossary** 

This glossary lists and explains terms, acronyms, and definitions.



# 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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#### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	<b>RoHS</b> (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
TPS65296RJER	Active	Production	VQFN-HR (RJE)   18	3000   LARGE T&R	Yes	Call TI   Sn	Level-2-260C-1 YEAR	-40 to 125	65296
TPS65296RJER.A	Active	Production	VQFN-HR (RJE)   18	3000   LARGE T&R	Yes	SN	Level-2-260C-1 YEAR	-40 to 125	65296
TPS65296RJER.B	Active	Production	VQFN-HR (RJE)   18	3000   LARGE T&R	Yes	SN	Level-2-260C-1 YEAR	-40 to 125	65296

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

# **PACKAGE MATERIALS INFORMATION**

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# TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width					
В0	Dimension designed to accommodate the component length					
K0	Dimension designed to accommodate the component thickness					
W	Overall width of the carrier tape					
P1	Pitch between successive cavity centers					

### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPS65296RJER	VQFN- HR	RJE	18	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2

# **PACKAGE MATERIALS INFORMATION**

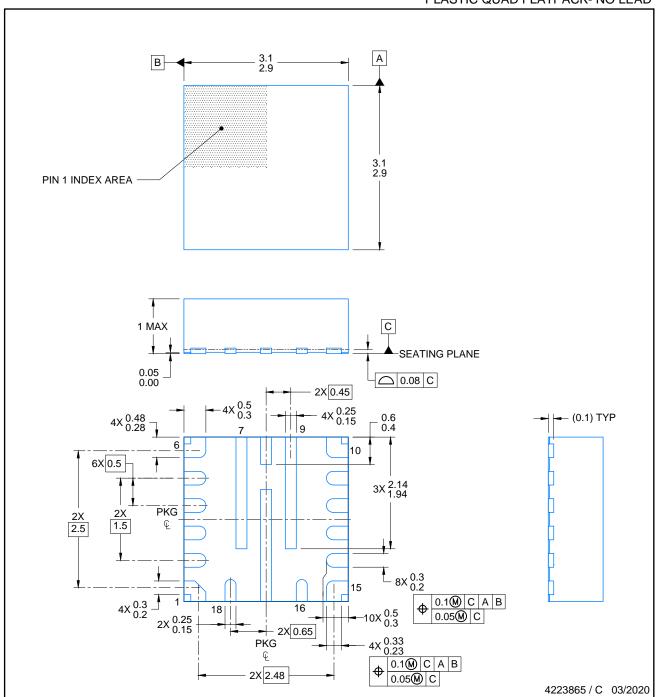
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# \*All dimensions are nominal

Device Package T		Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
TPS65296RJER	VQFN-HR	RJE	18	3000	346.0	346.0	80.0	

PLASTIC QUAD FLATPACK- NO LEAD

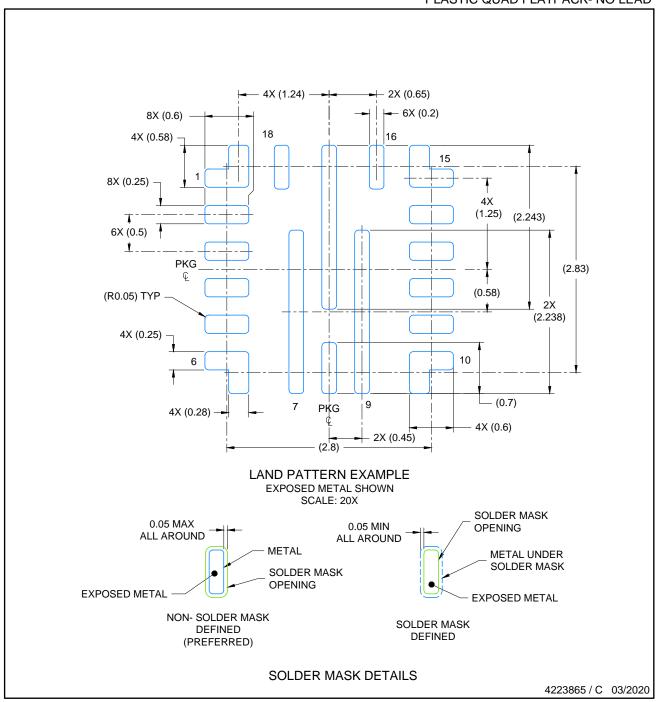


# NOTES:

- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.



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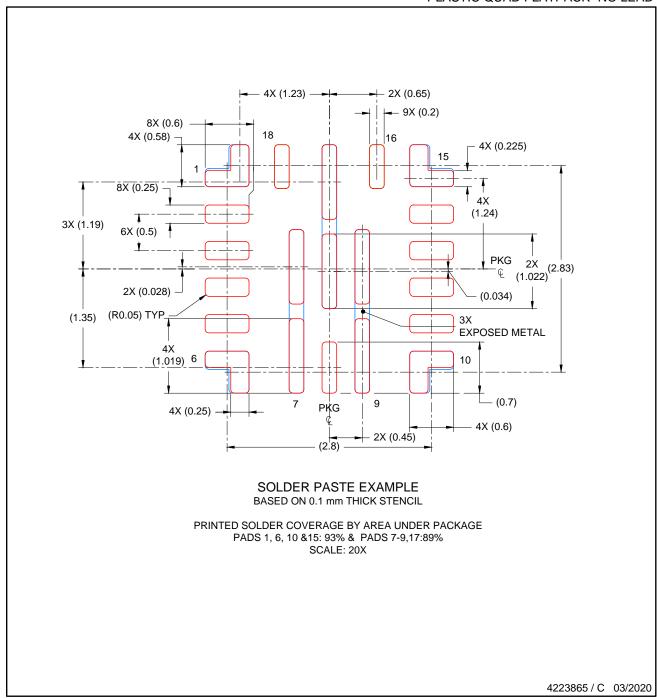


NOTES: (continued)

- 3. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 4. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



PLASTIC QUAD FLATPACK- NO LEAD



NOTES: (continued)

Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations..



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